

<b>Notice of References Cited</b>	Application/Control No. 09/932,202	Applicant(s)/Patent Under Reexamination ELMAN ET AL.	
	Examiner Olisa Anwah	Art Unit 2645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0137945	07-2004	Takagi et al.	455/558
*	B	US-2002/0160751	10-2002	Sun et al.	455/412
*	C	US-2003/0032447	02-2003	Bulthuis, Willem	455/556
*	D	US-2003/0012346	01-2003	Langhart et al.	379/67.1
*	E	US-6,529,602	03-2003	Walker et al.	380/283
*	F	US-6,072,860	06-2000	Kek et al.	379/88.25
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.